## FEATURES

2-channel, 256-position
OTP (one-time programmable) set-and-forget resistance setting, low cost alternative to EEMEM
Unlimited adjustments prior to OTP activation
OTP overwrite allows dynamic adjustments with user

## defined preset

End-to-end resistance: $2.5 \mathrm{k} \Omega, 10 \mathrm{k} \Omega, 50 \mathrm{k} \Omega, 100 \mathrm{k} \Omega$
Compact MSOP-10 ( $3 \mathrm{~mm} \times 4.9 \mathrm{~mm}$ ) package
Fast settling time: $\mathrm{ts}_{\mathrm{s}}=5 \mu \mathrm{~s}$ typ in power-up
Full read/write of wiper register
Power-on preset to midscale
Extra package address decode pins AD0 and AD1 (AD5173)
Single supply 2.7 V to 5.5 V
Low temperature coefficient: $35 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$
Low power, Iod $=6 \mu$ A max
Wide operating temperature: $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$
Evaluation board and software are available
Software replaces $\mu \mathrm{C}$ in factory programming applications

## APPLICATIONS

## Systems calibration

Electronics level setting
Mechanical Trimmers ${ }^{\ominus}$ replacement in new designs
Permanent factory PCB setting
Transducer adjustment of pressure, temperature, position, chemical, and optical sensors
RF amplifier biasing
Automotive electronics adjustment
Gain control and offset adjustment

## GENERAL OVERVIEW

The AD5172/AD5173 are dual channel, 256-position, one-time programmable (OTP) digital potentiometers ${ }^{1}$ that employ fuse link technology to achieve memory retention of resistance setting. OTP is a cost-effective alternative to EEMEM for users who do not need to program the digital potentiometer setting in memory more than once. This device performs the same electronic adjustment function as mechanical potentiometers or variable resistors with enhanced resolution, solid-state reliability, and superior low temperature coefficient performance.

The AD5172/AD5173 are programmed using a 2-wire, $\mathrm{I}^{2} \mathrm{C}$ compatible digital interface. Unlimited adjustments are allowed before permanently setting the resistance value. During OTP activation, a permanent blow fuse command freezes the wiper position (analogous to placing epoxy on a mechanical trimmer).

## Rev. A

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FUNCTIONAL BLOCK DIAGRAMS


Figure 1. AD5172


Figure 2. AD5173
Unlike traditional OTP digital potentiometers, the AD5172/ AD5173 have a unique temporary OTP overwrite feature that allows for new adjustments even after the fuse has been blown. However, the OTP setting is restored during subsequent powerup conditions. This feature allows users to treat these digital potentiometers as volatile potentiometers with a programmable preset.

For applications that program the AD5172/AD5173 at the factory, Analog Devices offers device programming software running on Windows ${ }^{\star} \mathrm{NT}^{\star}, 2000$, and $\mathrm{XP}^{\star}$ operating systems. This software effectively replaces any external $I^{2} \mathrm{C}$ controllers, thus enhancing the time-to-market of the user's systems.
'The terms digital potentiometer, VR, and RDAC are used interchangeably.

## AD5172/AD5173

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## REVISION HISTORY

## Revision A

11/03-Data Sheet Changed from Rev. 0 to Rev. A
Change Location

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## ELECTRICAL CHARACTERISTICS— $2.5 \mathrm{k} \Omega$

Table 1. $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \pm 10 \%$ or $3 \mathrm{~V} \pm 10 \% ; \mathrm{V}_{\mathrm{A}}=+\mathrm{V}_{\mathrm{DD}} ; \mathrm{V}_{\mathrm{B}}=0 \mathrm{~V} ;-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+125^{\circ} \mathrm{C}$; unless otherwise noted

| Parameter | Symbol | Conditions | Min | Typ ${ }^{1}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DC CHARACTERISTICS—RHEOSTAT MOD <br> Resistor Differential Nonlinearity ${ }^{2}$ <br> Resistor Integral Nonlinearity ${ }^{2}$ <br> Nominal Resistor Tolerance ${ }^{3}$ <br> Resistance Temperature Coefficient RWB (Wiper Resistance) | R-DNL <br> R-INL <br> $\Delta R_{A B}$ <br> $\left(\Delta R_{A B} / R_{A B}\right) / \Delta T$ <br> Rwb | Rwb, $\mathrm{V}_{\mathrm{A}}=$ No Connect <br> Rwb, $V_{A}=$ No Connect <br> $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ <br> $\mathrm{V}_{\mathrm{AB}}=\mathrm{V}_{\mathrm{DD}}$, Wiper $=$ No Connect <br> Code $=0 \times 00, ~ V D D=5 \mathrm{~V}$ | $\begin{aligned} & -2 \\ & -6 \\ & -20 \end{aligned}$ | $\begin{aligned} & \pm 0.1 \\ & \pm 0.75 \\ & \\ & 35 \\ & 160 \end{aligned}$ | $\begin{aligned} & +2 \\ & +6 \\ & +55 \\ & \\ & 200 \end{aligned}$ | $\begin{aligned} & \text { LSB } \\ & \text { LSB } \\ & \% \\ & \mathrm{ppm} /{ }^{\circ} \mathrm{C} \\ & \Omega \end{aligned}$ |
| DC CHARACTERISTICS—POTENTIOMETER <br> Differential Nonlinearity ${ }^{4}$ <br> Integral Nonlinearity ${ }^{4}$ <br> Voltage Divider Temperature <br> Coefficient <br> Full-Scale Error <br> Zero-Scale Error | VIDER MODE <br> DNL <br> INL <br> $\left(\Delta \mathrm{V}_{\mathrm{w}} / \mathrm{V}_{\mathrm{w}}\right) / \Delta \mathrm{T}$ <br> $V_{\text {wfSE }}$ <br> VWzse | pecifications Apply to all VRs) <br> Code $=0 \times 80$ $\begin{aligned} & \text { Code }=0 \times F F \\ & \text { Code }=0 \times 00 \end{aligned}$ | $\begin{aligned} & -1.5 \\ & -2 \\ & \\ & -10 \\ & 0 \\ & \hline \end{aligned}$ | $\begin{aligned} & \pm 0.1 \\ & \pm 0.6 \\ & 15 \\ & \\ & -2.5 \\ & 2 \\ & \hline \end{aligned}$ | $\begin{aligned} & +1.5 \\ & +2 \\ & 0 \\ & 10 \\ & \hline \end{aligned}$ | LSB ppm $/{ }^{\circ} \mathrm{C}$ LSB <br> LSB |
| RESISTOR TERMINALS <br> Voltage Range ${ }^{5}$ <br> Capacitance ${ }^{6}$ A, B <br> Capacitance W <br> Shutdown Supply Current ${ }^{7}$ Common-Mode Leakage | $\begin{aligned} & \mathrm{V}_{\mathrm{A}}, \mathrm{~V}_{\mathrm{B}}, \mathrm{~V}_{\mathrm{W}} \\ & \mathrm{C}_{\mathrm{A}}, \mathrm{C}_{\mathrm{B}} \\ & \mathrm{C}_{\mathrm{W}} \\ & \mathrm{I}_{\mathrm{A} \_\mathrm{SD}} \\ & \mathrm{I}_{\mathrm{CM}} \\ & \hline \end{aligned}$ | $\begin{aligned} & \mathrm{f}=1 \mathrm{MHz} \text {, Measured to GND, } \\ & \mathrm{Code}=0 \times 80 \\ & \mathrm{f}=1 \mathrm{MHz} \text {, Measured to GND, } \\ & \text { Code }=0 \times 80 \\ & \mathrm{~V}_{\mathrm{DD}}=5.5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{A}}=\mathrm{V}_{\mathrm{B}}=\mathrm{V}_{\mathrm{DD}} / 2 \end{aligned}$ | GND | 45 <br> 60 <br> 0.01 <br> 1 | $V_{\text {DD }}$ | V <br> pF <br> pF <br> $\mu \mathrm{A}$ <br> nA |
| DIGITAL INPUTS AND OUTPUTS <br> Input Logic High <br> Input Logic Low <br> Input Logic High <br> Input Logic Low <br> Input Current <br> Input Capacitance ${ }^{6}$ | $\mathrm{V}_{\mathrm{IH}}$ <br> VIL <br> $\mathrm{V}_{\mathrm{H}}$ <br> VIL <br> ILL <br> Cil | $\begin{aligned} & V_{D D}=5 \mathrm{~V} \\ & V_{D D}=5 \mathrm{~V} \\ & V_{D D}=3 \mathrm{~V} \\ & V_{D D}=3 \mathrm{~V} \\ & \mathrm{~V}_{1 \mathrm{D}}=0 \mathrm{~V} \text { or } 5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 2.4 \\ & 2.1 \end{aligned}$ | 5 | $\begin{aligned} & 0.8 \\ & \\ & 0.6 \\ & \pm 1 \end{aligned}$ |  |
| POWER SUPPLIES <br> Power Supply Range OTP Supply Voltage Supply Current OTP Supply Current Power Dissipation ${ }^{8}$ Power Supply Sensitivity | Vddrange <br> VDD_otP <br> IdD <br> IDD_OTP <br> PDISS <br> PSS | $\begin{aligned} & \mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \\ & \mathrm{~V}_{\mathrm{HH}}=5 \mathrm{~V} \text { or } \mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DD} \_ \text {otp }}=6 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C} \\ & \mathrm{~V}_{\mathrm{H}}=5 \mathrm{~V} \text { or } \mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V} \pm 10 \%, \text { Code }=\text { Midscale } \end{aligned}$ | $\begin{aligned} & 2.7 \\ & 6 \\ & 100 \end{aligned}$ | $3.5$ $\pm 0.02$ | $\begin{aligned} & 5.5 \\ & 6.5 \\ & 6 \\ & \\ & 30 \\ & \pm 0.08 \end{aligned}$ | V <br> V <br> $\mu \mathrm{A}$ <br> mA <br> $\mu \mathrm{W}$ <br> \%/\% |
| DYNAMIC CHARACTERISTICS ${ }^{9}$ <br> Bandwidth -3 dB <br> Total Harmonic Distortion Vw Settling Time Resistor Noise Voltage Density | $\begin{aligned} & \text { BW_2.5K } \\ & \text { THD }_{w} \\ & \mathrm{t}_{\mathrm{s}} \\ & \text { enn_wb }^{2} \end{aligned}$ | $\begin{aligned} & \text { Code }=0 \times 80 \\ & V_{A}=1 \mathrm{Vrms}, V_{B}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{kHz} \\ & \mathrm{~V}_{\mathrm{A}}=5 \mathrm{~V}, \mathrm{~V}_{\mathrm{B}}=0 \mathrm{~V}, \pm 1 \mathrm{LSB} \text { Error Band } \\ & \mathrm{Rw}_{\mathrm{w}}=1.25 \mathrm{k} \Omega, \mathrm{R}_{\mathrm{S}}=0 \end{aligned}$ |  | $\begin{aligned} & 4.8 \\ & 0.1 \\ & 1 \\ & 3.2 \end{aligned}$ |  | MHz <br> \% <br> $\mu \mathrm{s}$ <br> $\mathrm{nV} / \sqrt{ } \mathrm{Hz}$ |

[^1]
## ELECTRICAL CHARACTERISTICS—10 k $\Omega, 50 \mathrm{k} \Omega, 100 \mathrm{k} \Omega$ VERSIONS

Table 2. $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \pm 10 \%$ or $3 \mathrm{~V} \pm 10 \% ; \mathrm{V}_{\mathrm{A}}=\mathrm{V}_{\mathrm{DD}} ; \mathrm{V}_{\mathrm{B}}=0 \mathrm{~V} ;-40^{\circ} \mathrm{C}<\mathrm{T}_{\mathrm{A}}<+125^{\circ} \mathrm{C}$; unless otherwise noted

| Parameter | Symbol | Conditions | Min | Typ ${ }^{1}$ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DC CHARACTERISTICS—RHEOSTAT MODE <br> Resistor Differential Nonlinearity ${ }^{2}$ <br> Resistor Integral Nonlinearity ${ }^{2}$ <br> Nominal Resistor Tolerance ${ }^{3}$ Resistance Temperature Coefficient Rwe (Wiper Resistance) | R-DNL <br> R-INL <br> $\Delta \mathrm{R}_{\mathrm{AB}}$ <br> $\left(\Delta R_{A B} / R_{A B}\right) / \Delta T$ <br> Rwb | Rwb, $V_{A}=$ No Connect <br> $R_{w b,} V_{A}=$ No Connect <br> $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ <br> $\mathrm{V}_{\mathrm{AB}}=\mathrm{V}_{\mathrm{DD}}$, Wiper $=$ No Connect <br> Code $=0 \times 00, V_{D D}=5 \mathrm{~V}$ | $\begin{aligned} & -1 \\ & -2.5 \\ & -20 \end{aligned}$ | $\begin{aligned} & \pm 0.1 \\ & \pm 0.25 \\ & \\ & 35 \\ & 160 \end{aligned}$ | $\begin{aligned} & +1 \\ & +2.5 \\ & +20 \\ & \\ & 200 \\ & \hline \end{aligned}$ | $\begin{aligned} & \text { LSB } \\ & \text { LSB } \\ & \% \\ & \mathrm{ppm} /{ }^{\circ} \mathrm{C} \\ & \Omega \end{aligned}$ |
| DC CHARACTERISTICS—POTENTIOMETER DI <br> Differential Nonlinearity ${ }^{4}$ <br> Integral Nonlinearity ${ }^{4}$ <br> Voltage Divider Temperature Coefficient <br> Full-Scale Error <br> Zero-Scale Error | ER MODE (Spe <br> DNL <br> INL <br> $\left(\Delta \mathrm{V}_{\mathrm{w}} / \mathrm{V}_{\mathrm{w}}\right) / \Delta \mathrm{T}$ <br> $V_{\text {wFSE }}$ <br> V WzsE | ications Apply to all VRs) $\begin{aligned} & \text { Code }=0 \times 80 \\ & \text { Code }=0 \times F F \\ & \text { Code }=0 \times 00 \end{aligned}$ | $\begin{aligned} & -1 \\ & -1 \\ & -2.5 \\ & 0 \end{aligned}$ | $\begin{aligned} & \pm 0.1 \\ & \pm 0.3 \\ & 15 \\ & -1 \\ & 1 \\ & \hline \end{aligned}$ | $\begin{aligned} & +1 \\ & +1 \\ & 0 \\ & 0.5 \end{aligned}$ | $\begin{aligned} & \text { LSB } \\ & \text { LSB } \\ & \mathrm{ppm} /{ }^{\circ} \mathrm{C} \\ & \text { LSB } \\ & \text { LSB } \end{aligned}$ |
| RESISTOR TERMINALS <br> Voltage Range ${ }^{5}$ <br> Capacitance ${ }^{6}$ A, B <br> Capacitance ${ }^{6}$ W <br> Shutdown Supply Current ${ }^{7}$ <br> Common-Mode Leakage | $\begin{aligned} & V_{A}, V_{B}, V_{W} \\ & C_{A}, C_{B} \\ & C_{W} \\ & I_{A \_S D} \\ & I_{C M} \end{aligned}$ | $\begin{aligned} & f=1 \mathrm{MHz}, \text { Measured to GND, Code }=0 \times 80 \\ & f=1 \mathrm{MHz}, \text { Measured to GND, Code }=0 \times 80 \\ & V_{D D}=5.5 \mathrm{~V} \\ & V_{A}=V_{B}=V_{D D} / 2 \end{aligned}$ | GND | $\begin{aligned} & 45 \\ & 60 \\ & 0.01 \\ & 1 \end{aligned}$ | $V_{D D}$ 1 | pF <br> pF <br> $\mu \mathrm{A}$ <br> nA |
| DIGITAL INPUTS AND OUTPUTS <br> Input Logic High <br> Input Logic Low <br> Input Logic High <br> Input Logic Low <br> Input Current <br> Input Capacitance ${ }^{6}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{H}} \\ & \mathrm{~V}_{\mathrm{IL}} \\ & \mathrm{~V}_{\mathrm{HH}} \\ & \mathrm{~V}_{\mathrm{IL}} \\ & \mathrm{IIL}^{2} \\ & \mathrm{C}_{\mathrm{I}} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DD}}=3 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DD}}=3 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{IN}}=0 \mathrm{~V} \text { or } 5 \mathrm{~V} \end{aligned}$ | 2.4 2.1 | 5 | $\begin{aligned} & 0.8 \\ & 0.6 \\ & \pm 1 \end{aligned}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mu \mathrm{~A} \\ & \mathrm{pF} \end{aligned}$ |
| POWER SUPPLIES <br> Power Supply Range OTP Supply Voltage ${ }^{8}$ Supply Current OTP Supply Current ${ }^{9}$ Power Dissipation ${ }^{10}$ Power Supply Sensitivity | Vddrange <br> VD_otp <br> ID <br> IDD_OTP <br> PoIss <br> PSS | $\mathrm{V}_{\mathrm{H}}=5 \mathrm{~V} \text { or } \mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V}$ $\begin{aligned} & V_{\text {IH }}=5 \mathrm{~V} \text { or } \mathrm{V}_{\mathrm{IL}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=5 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{DD}}=+5 \mathrm{~V} \pm 10 \%, \text { code }=\text { Midscale } \end{aligned}$ | $\begin{aligned} & 2.7 \\ & 6 \\ & 100 \end{aligned}$ | $3.5$ $\pm 0.02$ | $\begin{aligned} & 5.5 \\ & 6.5 \\ & 6 \\ & \\ & 30 \\ & \pm 0.08 \end{aligned}$ | V <br> $\mu \mathrm{A}$ <br> mA <br> $\mu \mathrm{W}$ <br> \%/\% |
| DYNAMIC CHARACTERISTICS ${ }^{11}$ <br> Bandwidth -3 dB <br> Total Harmonic Distortion $\mathrm{V}_{\mathrm{w}}$ Settling Time ( $10 \mathrm{k} \Omega / 50 \mathrm{k} \Omega / 100 \mathrm{k} \Omega$ ) Resistor Noise Voltage Density | BW <br> THDw <br> ts <br> $\mathrm{e}_{\mathrm{N}, \mathrm{Wb}}$ | $\begin{aligned} & \mathrm{R}_{A B}=10 \mathrm{k} \Omega, \text { Code }=0 \times 80 \\ & \mathrm{R}_{A B}=50 \mathrm{k} \Omega, \text { code }=0 \times 80 \\ & \mathrm{R}_{A B}=100 \mathrm{k} \Omega, \operatorname{code}=0 \times 80 \\ & \mathrm{~V}_{A}=1 \mathrm{Vrms}, \mathrm{~V}_{\mathrm{B}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{kHz}, \mathrm{R}_{A B}=10 \mathrm{k} \Omega \\ & \mathrm{~V}_{A}=5 \mathrm{~V}, \mathrm{~V}_{B}=0 \mathrm{~V}, \pm 1 \mathrm{LSB} \text { Error Band } \\ & \mathrm{R}_{\mathrm{WB}}=5 \mathrm{k} \Omega, \mathrm{R}_{\mathrm{S}}=0 \end{aligned}$ |  | $\begin{aligned} & 600 \\ & 100 \\ & 40 \\ & 0.1 \\ & 2 \\ & 9 \end{aligned}$ |  | kHz <br> kHz <br> kHz <br> \% <br> $\mu \mathrm{s}$ <br> $\mathrm{nV} / \sqrt{ } \mathrm{Hz}$ |

[^2]
## TIMING CHARACTERISTICS— $2.5 \mathrm{k} \Omega, 10 \mathrm{k} \Omega, 50 \mathrm{k} \Omega, 100 \mathrm{k} \Omega$ VERSIONS

Table 3. $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V} \pm \mathbf{1 0 \%}$ or $3 \mathrm{~V} \pm 10 \% ; \mathrm{V}_{\mathrm{A}}=\mathrm{V}_{\mathrm{DD}} ; \mathrm{V}_{\mathrm{B}}=0 \mathrm{~V} ;-\mathbf{4 0 ^ { \circ } \mathrm { C } < \mathrm { T } _ { \mathrm { A } } < + 1 2 5 ^ { \circ } \mathrm { C } \text { ; unless otherwise noted }}$

| Parameter | Symbol | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $1^{2} \mathrm{C}$ INTERFACE TIMING CHARACTERISTICS ${ }^{1}$ (Specifications Apply to All Parts) |  |  |  |  |  |  |
| SCL Clock Frequency | $\mathrm{f}_{\text {Scl }}$ |  |  |  | 400 | kHz |
| $\mathrm{t}_{\text {buf }}$ Bus Free Time between STOP and START | $\mathrm{t}_{1}$ |  | 1.3 |  |  | $\mu \mathrm{s}$ |
| $t_{\text {HD:STA }}$ Hold Time (Repeated START) | $\mathrm{t}_{2}$ | After this period, the first clock pulse is generated. | 0.6 |  |  | $\mu \mathrm{s}$ |
| tıow Low Period of SCL Clock | $\mathrm{t}_{3}$ |  | 1.3 |  |  | $\mu \mathrm{s}$ |
| $\mathrm{t}_{\text {HIGH }}$ High Period of SCL Clock | $\mathrm{t}_{4}$ |  | 0.6 |  |  | $\mu \mathrm{s}$ |
| tsu;Sta Setup Time for Repeated START Condition | $\mathrm{t}_{5}$ |  | 0.6 |  |  | $\mu \mathrm{s}$ |
|  | $\mathrm{t}_{6}$ |  |  |  | 0.9 | $\mu \mathrm{s}$ |
| $\mathrm{tsu}_{\text {; }}$ dit Data Setup Time | $\mathrm{t}_{7}$ |  | 100 |  |  | ns |
| $\mathrm{t}_{\mathrm{F}}$ Fall Time of Both SDA and SCL Signals | $\mathrm{t}_{8}$ |  |  |  | 300 | ns |
| $t_{R}$ Rise Time of Both SDA and SCL Signals | t9 |  |  |  | 300 | ns |
| $\mathrm{tsu}_{\text {siso }}$ Setup Time for STOP Condition | $\mathrm{t}_{10}$ |  | 0.6 |  |  | $\mu \mathrm{s}$ |

[^3]ABSOLUTE MAXIMUM RATINGS
Table 4. $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, unless otherwise noted

| Parameter | Value |
| :--- | :--- |
| $V_{D D}$ to GND | -0.3 V to +7 V |
| $\mathrm{~V}_{\mathrm{A}}, \mathrm{V}_{\mathrm{B}}, \mathrm{V}_{\mathrm{W}}$ to GND | $\mathrm{V}_{\mathrm{DD}}$ |
| Terminal Current, $\mathrm{Ax}-\mathrm{Bx}, \mathrm{Ax}-\mathrm{Wx}, \mathrm{Bx}-\mathrm{W} x^{1}$ |  |
| $\quad$ Pulsed | $\pm 20 \mathrm{~mA}$ |
| $\quad$ Continuous | $\pm 5 \mathrm{~mA}$ |
| Digital Inputs and Output Voltage to GND | 0 V to 7 V |
| Operating Temperature Range | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| Maximum Junction Temperature (TJMax) | $150^{\circ} \mathrm{C}$ |
| Storage Temperature | $-65^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Lead Temperature (Soldering, 10 sec ) | $300^{\circ} \mathrm{C}$ |
| Thermal Resistance ${ }^{2} \theta_{\mathrm{JA}}: \mathrm{MSOP}-10$ | $230^{\circ} \mathrm{C} / \mathrm{W}$ |

${ }^{1}$ Maximum terminal current is bound by the maximum current handling of the switches, maximum power dissipation of the package, and maximum applied voltage across any two of the $A, B$, and $W$ terminals at a given resistance.
${ }^{2}$ Package power dissipation $=\left(\mathrm{T}_{\mathrm{JMAX}}-\mathrm{T}_{\mathrm{A}}\right) / \theta_{\mathrm{JA}}$.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

## TYPICAL PERFORMANCE CHARACTERISTICS



Figure 3. R-INL vs. Code vs. Supply Voltages


Figure 4. R-DNL vs. Code vs. Supply Voltages


Figure 5. INL vs. Code vs. Temperature


Figure 6. DNL vs. Code vs. Temperature


Figure 7. INL vs. Code vs. Supply Voltages


Figure 8. DNL vs. Code vs. Supply Voltages

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Figure 9. R-INL vs. Code vs. Temperature


Figure 10. R-DNL vs. Code vs. Temperature


Figure 11. Full-Scale Error vs. Temperature


Figure 12. Zero-Scale Error vs. Temperature


Figure 13. Supply Current vs. Temperature


Figure 14. Rheostat Mode Tempco $\Delta R_{w b} / \Delta T$ vs. Code


Figure 15. AD5172 Potentiometer Mode Tempco $\Delta V_{w B} / \Delta T$ vs. Code


Figure 16. Gain vs. Frequency vs. Code, $R_{A B}=2.5 \mathrm{k} \Omega$


Figure 17. Gain vs. Frequency vs. Code, $R_{A B}=10 \mathrm{k} \Omega$


Figure 18. Gain vs. Frequency vs. Code, $R_{A B}=50 \mathrm{k} \Omega$


Figure 19. Gain vs. Frequency vs. Code, $R_{A B}=100 \mathrm{k} \Omega$


Figure 20. $-3 d B$ Bandwidth @ Code $=0 \times 80$

## AD5172/AD5173



Figure 21. IDD vs. Input Voltage


Figure 22. Digital Feedthrough


Figure 23. Digital Crosstalk


Figure 24. Analog Crosstalk


Figure 25. Midscale Glitch, Code 0x80 to 0x7F


Figure 26. Large Signal Settling Time

## TEST CIRCUITS

Figure 27 to Figure 34 illustrate the test circuits that define the test conditions used in the product specification tables.


Figure 27. Test Circuit for Potentiometer Divider Nonlinearity Error (INL, DNL)


Figure 28. Test Circuit for Resistor Position Nonlinearity Error (Rheostat Operation; R-INL, R-DNL)


Figure 29. Test Circuit for Wiper Resistance


Figure 31. Test Circuit for Gain vs. Frequency


Figure 32. Test Circuit for Incremental On Resistance


Figure 33. Test Circuit for Common-Mode Leakage Current


Figure 34. Test Circuit for Analog Crosstalk

## AD5172/AD5173

## OPERATION



Figure 35. Detailed Functional Block Diagram

The AD5172/AD5173 is a 256 -position, digitally controlled variable resistor (VR) that employs fuse link technology to achieve memory retention of resistance setting.

An internal power-on preset places the wiper at midscale during power-on. If the OTP function has been activated, the device powers up at the user-defined permanent setting.

## ONE-TIME PROGRAMMING (OTP)

Prior to OTP activation, the AD5172/AD5173 presets to midscale during initial power-on. After the wiper is set at the desired position, the resistance can be permanently set by programming the T bit high along with the proper coding (see Table 5 and Table 6). Note that fuse link technology requires 6 V to blow the internal fuses to achieve a given setting. The user is allowed only one attempt at blowing the fuses. Once programming is completed, the power supply voltage must be reduced to the normal operating range of 2.7 V to 5.5 V .

The device control circuit has two validation bits, E1 and E0, that can be read back to check the programming status (see Table 7). Users should always read back the validation bits to ensure that the fuses are properly blown. After the fuses have been blown, all fuse latches are enabled upon subsequent power-on; therefore, the output corresponds to the stored setting. Figure 35 shows a detailed functional block diagram.

## PROGRAMMING THE VARIABLE RESISTOR AND VOLTAGE Rheostat Operation

The nominal resistance of the RDAC between terminals A and B is available in $2.5 \mathrm{k} \Omega, 10 \mathrm{k} \Omega, 50 \mathrm{k} \Omega$, and $100 \mathrm{k} \Omega$. The nominal resistance ( $\mathrm{R}_{\mathrm{AB}}$ ) of the VR has 256 contact points accessed by the wiper terminal, plus the $B$ terminal contact. The 8 -bit data in the RDAC latch is decoded to select one of the 256 possible settings.


Figure 36. Rheostat Mode Configuration
Assuming a $10 \mathrm{k} \Omega$ part is used, the wiper's first connection starts at the B terminal for data $0 \times 00$. Because there is a $50 \Omega$ wiper contact resistance, such a connection yields a minimum of $100 \Omega(2 \times 50 \Omega)$ resistance between terminals W and B . The second connection is the first tap point, which corresponds to $139 \Omega\left(\mathrm{R}_{\mathrm{WB}}=\mathrm{R}_{\mathrm{AB}} / 256+2 \times \mathrm{R}_{\mathrm{W}}=39 \Omega+2 \times 50 \Omega\right)$ for data $0 \times 01$. The third connection is the next tap point, representing $178 \Omega(2 \times 39 \Omega+2 \times 50 \Omega)$ for data $0 \times 02$, and so on. Each LSB data value increase moves the wiper up the resistor ladder until the last tap point is reached at $10,100 \Omega\left(\mathrm{R}_{A B}+2 \times \mathrm{R}_{\mathrm{W}}\right)$.


Figure 37. AD5172/AD5173 Equivalent RDAC Circuit

The general equation that determines the digitally programmed output resistance between W and B is

$$
\begin{equation*}
R_{W B}(D)=\frac{D}{128} \times R_{A B}+2 \times R_{W} \tag{1}
\end{equation*}
$$

where $D$ is the decimal equivalent of the binary code loaded in the 8 -bit RDAC register, $R_{A B}$ is the end-to-end resistance, and $R_{W}$ is the wiper resistance contributed by the on resistance of the internal switch.

In summary, if $R_{A B}=10 \mathrm{k} \Omega$ and the $A$ terminal is opencircuited, the output resistance $\mathrm{R}_{\mathrm{wB}}$ is set for the RDAC latch codes, as shown in Table 5.

Table 5. Codes and Corresponding RWB Resistance

| D (Dec.) | Rwb $(\mathbf{\Omega})$ | Output State |
| :--- | :--- | :--- |
| 255 | 9,961 | Full-Scale (RAB -1 LSB + Rw) |
| 128 | 5,060 | Midscale |
| 1 | 139 | 1 LSB |
| 0 | 100 | Zero-Scale (Wiper Contact Resistance) |

Note that in the zero-scale condition, a finite wiper resistance of $100 \Omega$ is present. Care should be taken to limit the current flow between W and B in this state to a maximum pulse current of no more than 20 mA . Otherwise, degradation or possible destruction of the internal switch contact can occur.

Similar to the mechanical potentiometer, the resistance of the RDAC between the wiper W and terminal A also produces a digitally controlled complementary resistance, $R_{\text {WA }}$. When these terminals are used, the B terminal can be opened. Setting the resistance value for $R_{W A}$ starts at a maximum value of resistance and decreases as the data loaded in the latch increases in value. The general equation for this operation is

$$
\begin{equation*}
R_{W A}(D)=\frac{256-D}{128} \times R_{A B}+2 \times R_{W} \tag{2}
\end{equation*}
$$

For $R_{A B}=10 \mathrm{k} \Omega$ and the B terminal open-circuited, the following output resistance $R_{W A}$ is set for the RDAC latch codes, as shown in Table 6.

Table 6. Codes and Corresponding Rwa $_{\text {wes }}$ Resistance

| D (Dec.) | Rwa $\boldsymbol{\Omega})$ | Output State |
| :--- | :--- | :--- |
| 255 | 139 | Full-Scale |
| 128 | 5,060 | Midscale |
| 1 | 9,961 | 1 LSB |
| 0 | 10,060 | Zero-Scale |

Typical device-to-device matching is process lot dependent and may vary by up to $\pm 30 \%$. Because the resistance element is processed using thin film technology, the change in $\mathrm{R}_{\mathrm{AB}}$ with temperature has a very low $35 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$ temperature coefficient.

## PROGRAMMING THE POTENTIOMETER DIVIDER Voltage Output Operation

The digital potentiometer easily generates a voltage divider at wiper-to-B and wiper-to-A proportional to the input voltage at A-to-B. Unlike the polarity of $\mathrm{V}_{\mathrm{DD}}$ to GND, which must be positive, voltage across A-B, W-A, and $\mathrm{W}-\mathrm{B}$ can be at either polarity.


Figure 38. Potentiometer Mode Configuration

If ignoring the effect of the wiper resistance for approximation, connecting the A terminal to 5 V and the B terminal to ground produces an output voltage at the wiper-to- B starting at 0 V up to 1 LSB less than 5 V . Each LSB of voltage is equal to the voltage applied across terminal AB divided by the 256 positions of the potentiometer divider. The general equation defining the output voltage at $V_{W}$ with respect to ground for any valid input voltage applied to terminals A and B is

$$
\begin{equation*}
V_{W}(D)=\frac{D}{256} V_{A}+\frac{256-D}{256} V_{B} \tag{3}
\end{equation*}
$$

For a more accurate calculation, which includes the effect of wiper resistance, $V_{W}$ can be found as

$$
\begin{equation*}
V_{W}(D)=\frac{R_{W B}(D)}{R_{A B}} V_{A}+\frac{R_{W A}(D)}{R_{A B}} V_{B} \tag{4}
\end{equation*}
$$

Operation of the digital potentiometer in the divider mode results in a more accurate operation over temperature. Unlike the rheostat mode, the output voltage is dependent mainly on the ratio of the internal resistors $R_{W A}$ and $R_{W B}$ and not the absolute values. Thus, the temperature drift reduces to $15 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$.

## ESD PROTECTION

All digital inputs-SDA, SCL, AD0, and AD1 - are protected with a series input resistor and parallel Zener ESD structures, as shown in Figure 39 and Figure 40.


Figure 39. ESD Protection of Digital Pins


Figure 40. ESD Protection of Resistor Terminals

## TERMINAL VOLTAGE OPERATING RANGE

The AD5172/AD5173 V $\mathrm{V}_{\mathrm{DD}}$ to GND power supply defines the boundary conditions for proper 3-terminal digital potentiometer operation. Supply signals present on terminals A, B, and W that exceed $V_{D D}$ or GND are clamped by the internal forwardbiased diodes (see Figure 41).


Figure 41. Maximum Terminal Voltages Set by $V_{D D}$ and GND

## POWER-UP SEQUENCE

Because the ESD protection diodes limit the voltage compliance at terminals A, B, and W (see Figure 41), it is important to power $V_{D D} / G N D$ before applying any voltage to terminals $A, B$, and W. Otherwise, the diode will be forward biased such that $V_{D D}$ is powered unintentionally and may affect the rest of the user's circuit. The ideal power-up sequence is GND, $V_{D D}$, the digital inputs, and then $V_{A} / V_{B} / V_{w}$. The relative order of powering $\mathrm{V}_{\mathrm{A}}, \mathrm{V}_{\mathrm{B}}, \mathrm{V}_{\mathrm{W}}$, and the digital inputs is not important as long as they are powered after $V_{D D} / G N D$.

## POWER SUPPLY CONSIDERATIONS

To minimize the package pin count, both the one-time programming and normal operating voltage supplies are applied to the same VDD terminal of the AD5172/AD5173. The AD5172/ AD5173 employ fuse link technology that requires 6 V to blow the internal fuses to achieve a given setting. The user is allowed only one attempt at blowing the fuses. Once programming is completed, power supply voltage must be reduced to the normal 2.7 V to 5.5 V operating range. Such dual voltage requirements require isolation between the supplies. The fuse programming supply (either an on-board regulator or rack-mount power supply) must be rated at 6 V and must be able to provide a 100 mA transient current for 400 ms for successful one-time programming. Once programming is complete, the 6 V supply must be removed to allow normal operation at 2.7 V to 5.5 V at regular microamp current levels. Figure 42 shows the simplest implementation using a jumper. This approach saves one voltage supply, but draws additional current and requires manual configuration.


Figure 42. Power Supply Requirement

An alternate approach in 3.5 V to 5.5 V systems adds a signal diode between the system supply and the OTP supply for isolation, as shown in Figure 43.


Figure 43. Isolate 6 V OTP Supply from 3.5 V to 5.5 V Normal Operating Supply. The 6 V supply must be removed once OTP is completed.

## AD5172/AD5173



Figure 44. Isolate 6 V OTP Supply from 2.7 V Normal Operating Supply. The 6 V supply must be removed once OTP is completed.

For users who operate their systems at 2.7 V , use of the bidirectional low threshold P-Ch MOSFETs is recommended for the supply's isolation. As shown in Figure 44, this assumes that the 2.7 V system voltage is applied first, and that the P1 and P 2 gates are pulled to ground, thus turning on P1 and subsequently P2. As a result, $\mathrm{V}_{\mathrm{DD}}$ of the AD5172/AD5173 approaches 2.7 V . When the AD5172/AD5173 setting is found, the factory tester applies the 6 V to $\mathrm{V}_{\mathrm{DD}}$; the 6 V is also applied to the gates of P1 and P2 to turn them off. The OTP command is executed at this time to program the AD5172/AD5173; the 2.7 V source is therefore protected. Once the OTP is completed, the tester withdraws the 6 V and the AD5172/AD5173's setting is fixed permanently.

AD5172/AD5173 achieves the OTP function through blowing internal fuses. Users should always apply the 6 V one-time program voltage requirement at the first program command. Failure to comply with this requirement may lead to the change of fuse structures, rendering programming inoperable.

Poor PCB layout introduces parasitics that may affect the fuse programming. Therefore, it is recommended to add a $1 \mu \mathrm{~F}$ tantalum capacitor in parallel with a 1 nF ceramic capacitor as close as possible to the $\mathrm{V}_{\mathrm{DD}}$ pin. These capacitors help ensure OTP programming success by providing proper current densities. This combination of capacitor values provides both a fast response for high frequency transients and a larger supply of current for extended spikes. Typically, C1 minimizes any transient disturbances and low frequency ripple, while C2 reduces high frequency noise.

## LAYOUT CONSIDERATIONS

It is a good practice to employ compact, minimum lead length layout design. The leads to the inputs should be as direct as possible with a minimum conductor length. Ground paths should have low resistance and low inductance.

Note that the digital ground should also be joined remotely to the analog ground at one point to minimize the ground bounce.


Figure 45. Power Supply Bypassing

## AD5172/AD5173

## EVALUATION SOFTWARE/HARDWARE



Figure 46. AD5172/AD5173 Computer Software Interface

There are two ways of controlling the AD5172/AD5173. Users can either program the devices with computer software or with external I ${ }^{2} \mathrm{C}$ controllers.

## SOFTWARE PROGRAMMING

Due to the advantages of the one-time programmable feature, users may consider programming the device in the factory before shipping the final product to end-users. ADI offers a device programming software that can be implemented in the factory on PCs running Windows 95 or later. As a result, external controllers are not required, which significantly reduces development time. The program is an executable file that does not require any programming languages or user programming skills. It is easy to set up and to use. Figure 46 shows the software interface. The software can be downloaded from www.analog.com.

The AD5172/AD5173 starts at midscale after power-up prior to OTP programming. To increment or decrement the resistance, the user may simply move the scrollbars on the left. To write any specific value, the user should use the bit pattern in the upper screen and press the Run button. The format of writing data to the device is shown in Table 7. Once the desired setting is found, the user may press the Program Permament button to blow the internal fuse links.

To read the validation bits and data out from the device, the user simply presses the Read button. The format of the read bits is shown in Table 8.

To apply the device programming software in the factory, users must modify a parallel port cable and configure Pins $2,3,15$, and 25 for SDA_write, SCL, SDA_read, and DGND, respectively, for the control signals (Figure 47). Users should also lay out the PCB of the AD5172/AD5173 with SCL and SDA pads, as shown in Figure 48, such that pogo pins can be inserted for factory programming.


Figure 48. Recommended AD5172/AD5173 PCB Layout. The SCL and SDA pads allow pogo pins to be inserted so that signals can be communicated through the parallel port for programming (Figure 47).

Figure 47. Parallel Port Connection. Pin $2=S D A \_$write, Pin $3=S C L$, Pin $15=$ SDA_read, and Pin $25=$ DGND.

## AD5172/AD5173

## I2C INTERFACE

## Table 7. Write Mode

AD5172


AD5173


Table 8. Read Mode
AD5172


AD5173


S = Start Condition
P = Stop Condition
A = Acknowledge
AD0, AD1 = Package Pin Programmable Address Bits
X = Don't Care
$\bar{W}=$ Write
$\mathrm{R}=$ Read
A $0=$ RDAC Subaddress Select Bit
SD = Shutdown connects wiper to B terminal and open circuits the A terminal. It does not change contents of wiper register.
$\mathrm{T}=$ OTP Programming Bit. Logic 1 programs the wiper permanently.

OW = Overwrite the fuse setting and program the digital potentiometer to a different setting. Note that upon power-up, the digital potentiometer is preset to either midscale or fuse setting, depending on whether not the fuse link has been blown.

D7, D6, D5, D4, D3, D2, D1, D0 = Data Bits.
$\mathrm{E} 1, \mathrm{E} 0=\mathrm{OTP}$ Validation Bits.
$0,0=$ Ready to Program.
1, $0=$ Fatal Error. Some fuses not blown. Do not retry. Discard this unit.

1,1 = Programmed Successfully. No further adjustments possible.


Figure 49. ${ }^{2}$ C Interface Detailed Timing Diagram


Figure 50. Writing to the RDAC Register—AD5172


Figure 51. Writing to the RDAC Register—AD5173


Figure 52. Reading Data from a Previously Selected RDAC Register in Write Mode—AD5172


Figure 53. Reading Data from a Previously Selected RDAC Register in Write Mode—AD5173

## AD5172/AD5173

## $I^{2} \mathrm{C}$ COMPATIBLE 2-WIRE SERIAL BUS

The 2 -wire $\mathrm{I}^{2} \mathrm{C}$ serial bus protocol operates as follows:

1. The master initiates data transfer by establishing a START condition, which is when a high-to-low transition on the SDA line occurs while SCL is high (see Figure 50 and Figure 51). The following byte is the slave address byte, which consists of the slave address followed by an $\mathrm{R} / \overline{\mathrm{W}}$ bit (this bit determines whether data is read from or written to the slave device). The AD5172 has a fixed slave address byte, whereas the AD5173 has two configurable address bits, AD0 and AD1 (see Figure 50 and Figure 51).

The slave whose address corresponds to the transmitted address responds by pulling the SDA line low during the ninth clock pulse (this is termed the acknowledge bit). At this stage, all other devices on the bus remain idle while the selected device waits for data to be written to or read from its serial register. If the $\mathrm{R} / \overline{\mathrm{W}}$ bit is high, the master reads from the slave device. If the $\mathrm{R} / \overline{\mathrm{W}}$ bit is low, the master writes to the slave device.
2. In the write mode, the second byte is the instruction byte. The first bit (MSB) of the instruction byte is the RDAC subaddress select bit. A logic low selects channel 1; a logic high selects channel 2.

The second MSB, SD, is a shutdown bit. A logic high causes an open circuit at terminal A while shorting the wiper to terminal B. This operation yields almost $0 \Omega$ in rheostat mode or 0 V in potentiometer mode. It is important to note that the shutdown operation does not disturb the contents of the register. When brought out of shutdown, the previous setting is applied to the RDAC. Also, during shutdown, new settings can be programmed. When the part is returned from shutdown, the corresponding VR setting is applied to the RDAC.

The third MSB, T, is the OTP programming bit. A logic high blows the poly fuses and programs the resistor setting permanently.

The fourth MSB must always be at Logic 0 .
The fifth MSB, OW, is an overwrite bit. When raised to a logic high, OW allows the RDAC setting to be changed even after the internal fuses have been blown. However, once OW is returned to a logic zero, the position of the RDAC returns to the setting prior to overwrite. Because OW is not static, if the device is powered off and on, the RDAC presets to midscale or to the setting at which the fuses were blown, depending on whether or not the fuses have been permanently set already.

The remainder of the bits in the instruction byte are don't cares (see Figure 50 and Figure 51).

After acknowledging the instruction byte, the last byte in write mode is the data byte. Data is transmitted over the serial bus in sequences of nine clock pulses (eight data bits followed by an acknowledge bit). The transitions on the SDA line must occur during the low period of SCL and remain stable during the high period of SCL (see Figure 49).
3. In the read mode, the data byte follows immediately after the acknowledgment of the slave address byte. Data is transmitted over the serial bus in sequences of nine clock pulses (a slight difference from the write mode, where there are eight data bits followed by an acknowledge bit). Similarly, the transitions on the SDA line must occur during the low period of SCL and remain stable during the high period of SCL (see Figure 52 and Figure 53).

Note that the channel of interest is the one that is previously selected in the write mode. In the case where users need to read the RDAC values of both channels, they must program the first channel in the write mode and then change to the read mode to read the first channel value. After that, the user must change back to the write mode with the second channel selected and read the second channel value in the read mode. It is not necessary for users to issue the Frame 3 data byte in the write mode for subsequent readback operation. Refer to Figure 52 and Figure 53 for the programming format.

Following the data byte, the validation byte contains two validation bits, E 0 and E 1 . These bits signify the status of the one-time programming (see Figure 52 and Figure 53).
4. After all data bits have been read or written, a STOP condition is established by the master. A STOP condition is defined as a low-to-high transition on the SDA line while SCL is high. In write mode, the master pulls the SDA line high during the $10^{\text {th }}$ clock pulse to establish a STOP condition (see Figure 50 and Figure 51). In read mode, the master issues a No Acknowledge for the ninth clock pulse (i.e., the SDA line remains high). The master then brings the SDA line low before the $10^{\text {th }}$ clock pulse, which goes high to establish a STOP condition (see Figure 52 and Figure 53).

A repeated write function gives the user flexibility to update the RDAC output a number of times after addressing and instructing the part only once. For example, after the RDAC has acknowledged its slave address and instruction bytes in the write mode, the RDAC output is updated on each successive byte. If different instructions are needed, the write/read mode has to start again with a new slave address, instruction, and data byte. Similarly, a repeated read function of the RDAC is also allowed.

## AD5172/AD5173

Table 9. Validation Status

| E1 | E0 | Status |
| :--- | :--- | :--- |
| 0 | 0 | Ready for Programming. |
| 1 | 0 | Fatal Error. Some fuses not blown. <br> Do not retry. Discard this unit. <br> Successful. No further <br> programming is possible. |

## Multiple Devices on One Bus(AD5173 Only)

Figure 54 shows four AD5173s on the same serial bus. Each has a different slave address because the states of their AD0 and AD1 pins are different. This allows each device on the bus to be written to or read from independently. The master device output bus line drivers are open-drain pull-downs in a fully $\mathrm{I}^{2} \mathrm{C}$ compatible interface.


Figure 54. Multiple AD5173s on One $I^{2} C$ Bus

## AD5172/AD5173

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS



Figure 55. AD5172 Pin Configuration


Figure 56. AD5173 Pin Configuration

Table 10. AD5172 Pin Function Descriptions

| Pin | Menmonic | Description |
| :--- | :--- | :--- |
| 1 | B1 | B1 Terminal. |
| 2 | A1 | A1 Terminal. |
| 3 | W2 | W2 Terminal. |
| 4 | GND | Digital Ground. |
| 5 | VDD | Positive Power Supply. |
| 6 | SCL | Serial Clock Input. Positive edge triggered. |
| 7 | SDA | Serial Data Input/Output. |
| 8 | A2 | A2 Terminal. |
| 9 | B2 | B2 Terminal. |
| 10 | W1 | W1 Terminal. |

Table 11.AD5173 Pin Function Descriptions

| Pin | Mnemonic | Description |
| :--- | :--- | :--- |
| 1 | B1 | B1 Terminal. |
| 2 | AD0 | Programmable Address Bit 0 for Multiple <br>  <br> 3 |
| Package Decoding. |  |  |
| 4 | W2 | WND |
| 5 | V. | Digital Ground. |
| 6 | SCL | Positive Power Supply. |
| 7 | SDA | Serial Clock Input. Positive edge triggered. |
| 8 | AD1 | Serial Data Input/Output. |
|  |  | Programmable Address Bit 1 for Multiple |
| 9 | B2 | P2 Termage Decoding. |
| 10 | W1 | W1 Terminal. |

## OUTLINE DIMENSIONS



Figure 57. 10-Lead Mini Small Outline Package [MSOP] (RM-10)
Dimensions shown in millimeters

## AD5172/AD5173

ORDERING GUIDE

| Model | $\mathrm{R}_{\mathrm{AB}}(\mathrm{k} \Omega)$ | Temperature Range | Package Description | Package Option | Branding |
| :---: | :---: | :---: | :---: | :---: | :---: |
| AD5172BRM2.5 | 2.5 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | DOU |
| AD5172BRM2.5-RL7 | 2.5 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | DOU |
| AD5172BRM10 | 10 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | DOV |
| AD5172BRM10-RL7 | 10 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D0V |
| AD5172BRM50 | 50 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D10 |
| AD5172BRM50-RL7 | 50 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D10 |
| AD5172BRM100 | 100 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D11 |
| AD5172BRM100-RL7 | 100 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D11 |
| AD5172EVAL ${ }^{1}$ |  |  | Evaluation Board |  |  |
| AD5173BRM2.5 | 2.5 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1K |
| AD5173BRM2.5-RL7 | 2.5 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1K |
| AD5173BRM10 | 10 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1L |
| AD5173BRM10-RL7 | 10 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1L |
| AD5173BRM50 | 50 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1M |
| AD5173BRM50-RL7 | 50 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1M |
| AD5173BRM100 | 100 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1N |
| AD5173BRM100-RL7 | 100 | $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | MSOP-10 | RM-10 | D1N |
| AD5173EVAL ${ }^{1}$ |  |  | Evaluation Board |  |  |

${ }^{1}$ The evaluation board is shipped with the $10 \mathrm{k} \Omega \mathrm{R}_{\mathrm{AB}}$ resistor option; however, the board is compatible with all available resistor value options.

Purchase of licensed $I^{2} C$ components of Analog Devices or one of its sublicensed Associated Companies conveys a license for the purchaser under the Philips $I^{2} C$ Patent Rights to use these components in an $I^{2} C$ system, provided that the system conforms to the $I^{2} C$ Standard Specification as defined by Philips.


[^0]:    Changes to Electrical Characteristics- $2.5 \mathrm{k} \Omega$. $\qquad$ .3

[^1]:    ${ }^{1}$ Typical specifications represent average readings at $25^{\circ} \mathrm{C}$ and $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$.
    ${ }^{2}$ Resistor position nonlinearity error, R-INL, is the deviation from an ideal value measured between the maximum resistance and the minimum resistance wiper positions. R-DNL measures the relative step change from ideal between successive tap positions. Parts are guaranteed monotonic.
    ${ }^{3} \mathrm{~V}_{\mathrm{AB}}=\mathrm{V}_{\mathrm{DD}}$, Wiper $\left(\mathrm{V}_{\mathrm{W}}\right)=$ no connect.
    ${ }^{4} \mathrm{INL}$ and DNL are measured at VW with the RDAC configured as a potentiometer divider similar to a voltage output D/A converter. $\mathrm{V}_{\mathrm{A}}=\mathrm{V}_{\mathrm{DD}}$ and $\mathrm{V}_{\mathrm{B}}=0 \mathrm{~V}$. DNL
    specification limits of $\pm 1$ LSB maximum are guaranteed monotonic operating conditions.
    ${ }^{5}$ Resistor terminals A, B, W have no limitations on polarity with respect to each other.
    ${ }^{6}$ Guaranteed by design and not subject to production test.
    ${ }^{7}$ Measured at the A terminal. The A terminal is open circuited in shutdown mode.
    ${ }^{8}$ PDISs is calculated from (loD $\times V_{D D}$ ). CMOS logic level inputs result in minimum power dissipation.
    ${ }^{9}$ All dynamic characteristics use $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$.

[^2]:    ${ }^{1}$ Typical specifications represent average readings at $25^{\circ} \mathrm{C}$ and $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$.
    ${ }^{2}$ Resistor position nonlinearity error, $\mathrm{R}-\mathrm{INL}$, is the deviation from an ideal value measured between the maximum resistance and the minimum resistance wiper positions. R-DNL measures the relative step change from ideal between successive tap positions. Parts are guaranteed monotonic.
    ${ }^{3} V_{A B}=V_{D D}$, Wiper $\left(V_{W}\right)=$ no connect.
    ${ }^{4}$ INL and DNL are measured at $\mathrm{V}_{\mathrm{w}}$ with the RDAC configured as a potentiometer divider similar to a voltage output D/A converter. $\mathrm{V}_{\mathrm{A}}=\mathrm{V}_{\mathrm{DD}}$ and $\mathrm{V}_{\mathrm{B}}=0 \mathrm{~V}$.
    DNL specification limits of $\pm 1$ LSB maximum are guaranteed monotonic operating conditions.
    ${ }^{5}$ Resistor terminals A, B, W have no limitations on polarity with respect to each other.
    ${ }^{6}$ Guaranteed by design and not subject to production test.
    ${ }^{7}$ Measured at the A terminal. The A terminal is open circuited in shutdown mode.
    ${ }^{8}$ Different from operating power supply, power supply OTP is used one time only.
    ${ }^{9}$ Different from operating current, supply current for OTP lasts approximately 400 ms for one time only.
    ${ }^{10} \mathrm{P}_{\text {DISs }}$ is calculated from (lod $\times \mathrm{V}_{\mathrm{DD}}$ ). CMOS logic level inputs result in minimum power dissipation.
    ${ }^{11}$ All dynamic characteristics use $\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$.

[^3]:    ${ }^{1}$ See timing diagrams for locations of measured values.
    ${ }^{2}$ The maximum $t_{\text {HD;DAT }}$ has only to be met if the device does not stretch the LOW period (tiow) of the SCL signal.

